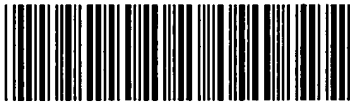


Search Notes

Application/Control No.

10/533,267

Examiner

Anthony Weier

Applicant(s)/Patent under
Reexamination

HAGIWARA ET AL.

Art Unit

1761

SEARCHED

Class	Subclass	Date	Examiner
426	634, 459, 285	3/17/2006	AW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search	3/17/2006	AW